STL18NM60N



N-channel 600 V, 0.26 Ω typ., 12 A MDmesh™ II Power MOSFET in a PowerFLAT™ 8x8 HV package

Datasheet - production data

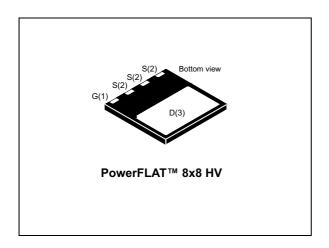
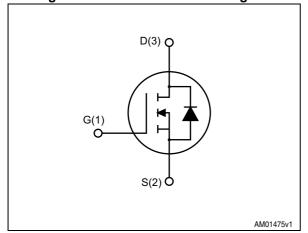


Figure 1. Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax}	R _{DS(on)} max	I _D
STL18NM60N	650 V	0.310 Ω	12 A (1)

- 1. The value is rated according to $R_{\text{thj-case}}$
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

Applications

Switching applications

Description

This device is an N-channel Power MOSFET developed using the second generation of MDmesh™ technology. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

	Order code	Marking	Packages	Packaging
•	STL18NM60N	18NM60N	PowerFLAT™ 8x8 HV	Tape and reel

Contents STL18NM60N

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STL18NM60N Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	600	V
V _{GS}	Gate-source voltage	± 30	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	12	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	7.5	Α
I _D ⁽²⁾	Drain current (continuous) at T _{amb} = 25 °C	2.1	Α
I _D ⁽²⁾	Drain current (continuous) at T _{amb} = 100 °C	1.2	Α
I _{DM} ^{(2),(3)}	Drain current (pulsed)	8.4	Α
P _{TOT} (2)	Total dissipation at T _{amb} = 25 °C	3	W
P _{TOT} ⁽¹⁾	Total dissipation at T _C = 25 °C	110	W
I _{AR}	Avalanche current, repetitive or not- repetitive (pulse width limited by T _j max)	4.5	А
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	350	mJ
dv/dt (4)	Peak diode recovery voltage slope	15	V/ns
T _{stg}	Storage temperature	- 55 to 150	°C
T _j Max. operating junction temperature		150	°C

- 1. The value is rated according to $R_{\mbox{\scriptsize thj-case}}$
- 2. When mounted on 1inch² FR-4 board, 2 oz Cu
- 3. Pulse width limited by safe operating area
- 4. $I_{SD} \leq$ 12 A, di/dt \leq 400 A/ μ s, $V_{DSpeak} \leq V_{(BR)DSS}$, V_{DD} = 80% $V_{(BR)DSS}$

Table 3. Thermal data

	Symbol	Parameter	Value	Unit
	R _{thj-case}	Thermal resistance junction-case max	1.14	°C/W
F	R _{thj-amb} ⁽¹⁾	Thermal resistance junction-amb max	42	°C/W

1. When mounted on 1inch² FR-4 board, 2 oz Cu

Electrical characteristics STL18NM60N

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	600			V
1	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 600 V			1	μΑ
I _{DSS}		V _{DS} = 600 V, T _C = 125 °C			100	μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 6 A		0.260	0.310	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1000	-	pF
C _{oss}	Output capacitance	$V_{DS} = 50 \text{ V, f} = 1 \text{ MHz,}$		60	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$		3	-	pF
C _{oss eq.} ⁽¹⁾	Output equivalent capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$	-	225	-	pF
R _G	Intrinsic gate resistance	f = 1, I _D =0	-	3.5	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 12 A,	-	35	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	6	-	nC
Q_{gd}	Gate-drain charge	(see Figure 14)	-	20	-	nC

^{1.} $C_{\rm oss~eq.}$ is defined as a constant equivalent capacitance giving the same charging time as $C_{\rm oss}$ when $V_{\rm DS}$ increases from 0 to 80% $V_{\rm DS}$.

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_{D} = 6.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 17)	-	12	-	ns
t _r	Rise time			15		ns
t _{d(off)}	Turn-on delay time			55		ns
t _f	Fall time			25		ns



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Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		12	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		48	Α
V _{SD} (2)	Forward on voltage	I _{SD} = 12 A, V _{GS} = 0	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 12 A, di/dt = 100 A/μs	-	300		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V	-	4.0		μC
I _{RRM}	Reverse recovery current	(see <i>Figure 15</i>)	-	25		Α
t _{rr}	Reverse recovery time	V _{DD} = 60 V	-	360		ns
Q _{rr}	Reverse recovery charge	di/dt = 100 A/µs, I _{SD} = 12 A	-	4.5		μC
I _{RRM}	Reverse recovery current	T _j =150 °C (see <i>Figure 15</i>)	-	25		Α

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

Electrical characteristics STL18NM60N

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

(A)

10

0.1

AM09775v1

10ms
100ms

1ms

10ms

Vbs(V)

Figure 3. Thermal impedance

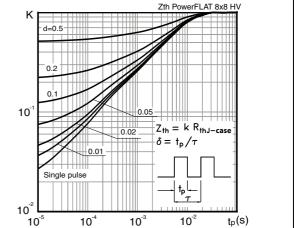
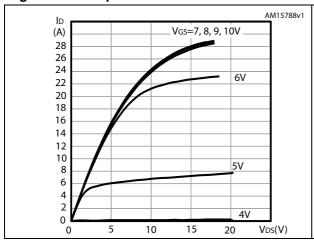


Figure 4. Output characteristics



10

100

Figure 5. Transfer characteristics

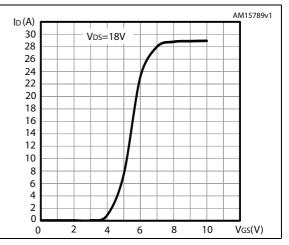


Figure 6. Normalized V_{DS} vs temperature

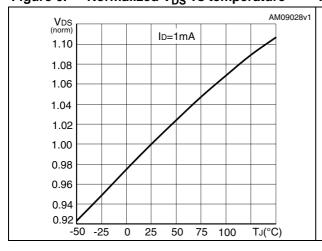
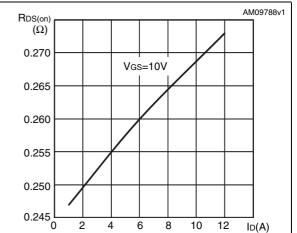


Figure 7. Static drain-source on-resistance



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AM05531v1 AM05532v1 Vgs V_{DS} (pF) (V) (V) VDD=480V 12 500 ID=12A 1000 Ciss 10 400 Vds 100 300 Coss 200 10 100 Crss VDS(V) 20 30 40 Qg(nC) 10 100 10 0.1 1

Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. vs temperature

Figure 11. Normalized on-resistance vs temperature

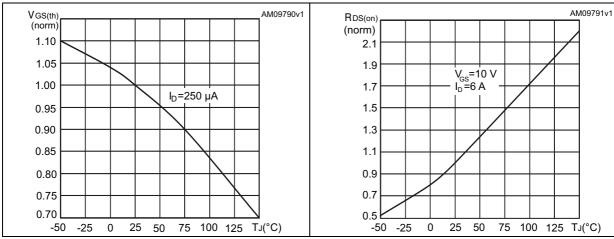
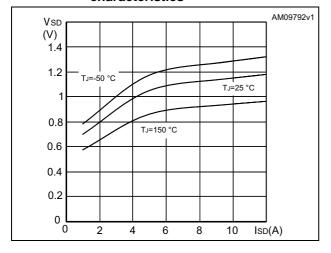


Figure 12. Source-drain diode forward characteristics



Test circuits STL18NM60N

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

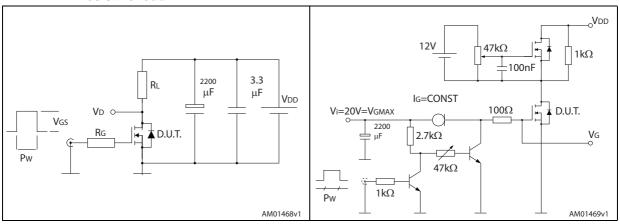


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

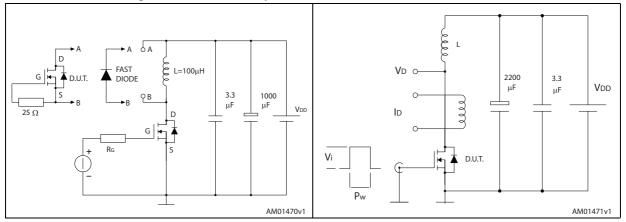
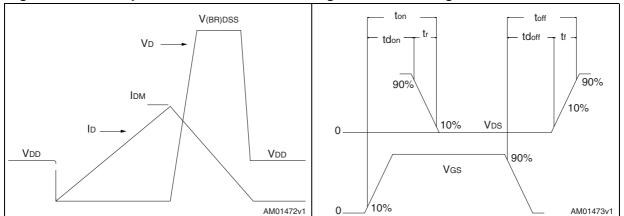


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.



Table 8. PowerFLAT™ 8x8 HV mechanical data

Dim.	mm				
Diiii.	Min.	Тур.	Max.		
Α	0.80	0.90	1.00		
A1	0.00	0.02	0.05		
b	0.95	1.00	1.05		
D		8.00			
E		8.00			
D2	7.05	7.20	7.30		
E2	4.15	4.30	4.40		
е		2.00			
L	0.40	0.50	0.60		

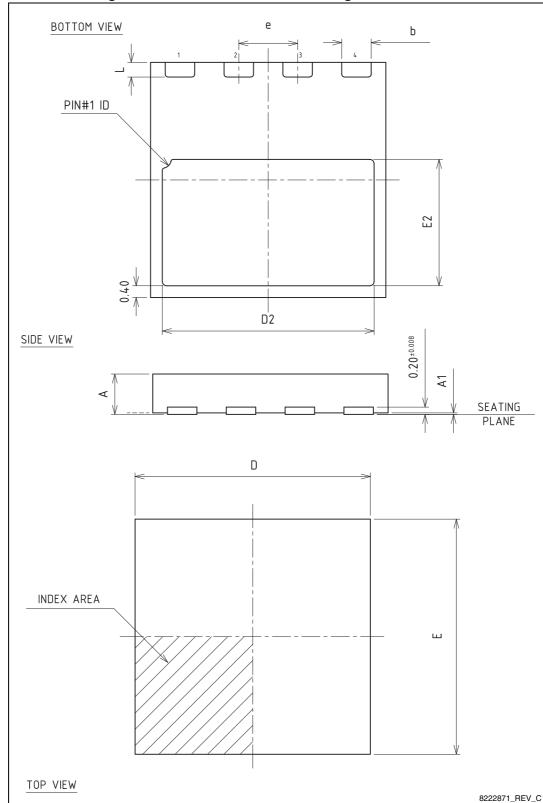


Figure 19. PowerFLAT™ 8x8 HV drawing mechanical data

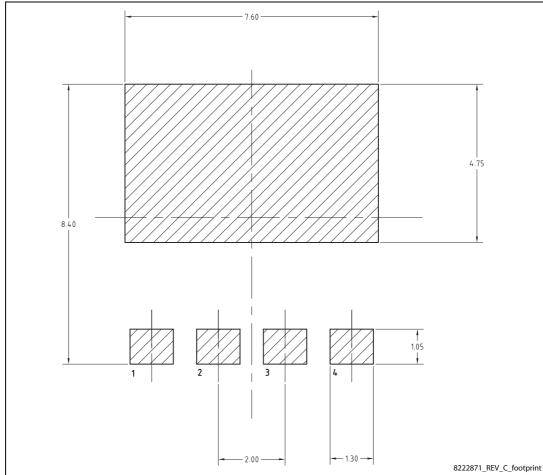


Figure 20. PowerFLAT™ 8x8 HV recommended footprint (dimensions in mm.)

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5 Packaging mechanical data

P2 (2.0±0.1)

T (0.30±0.05)

D1 (#1.55±0.05)

P1 (12.00±0.1)

P1 (12.00±0.1)

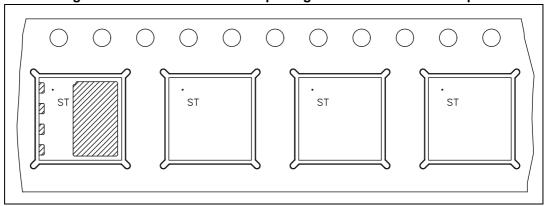
SECTION Y-Y

Note: Base and Bulk quantity 3000 pcs

8229819_Tape_revA

Figure 21. PowerFLAT™ 8x8 HV tape

Figure 22. PowerFLAT™ 8x8 HV package orientation in carrier tape.



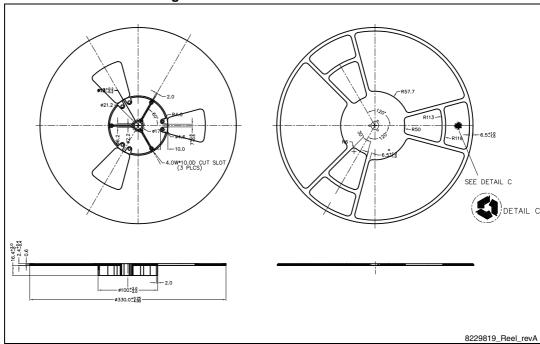


Figure 23. PowerFLAT™ 8x8 HV reel



STL18NM60N Revision history

6 Revision history

Table 9. Document revision history

Date	Revision	Changes
19-May-2011	1	First release.
03-Nov-2011	2	Section 4: Package mechanical data has been updated. Minor text changes.
28-Nov-2013	3	 Modified: title Modified: V_{GS}, I_{AR}, E_{AS} values in <i>Table 2</i> Modified: note 2 in <i>Table 2</i> Modified: R_{thj-amb} value in <i>Table 3</i> Modified: I_D value in <i>Table 5</i> Modified: the entire typical value in <i>Table 6</i> Modified: I_{SD} value in <i>Table 6</i> Modified: <i>Figure 3, 4, 5, 13, 14, 15</i>, and 16 Updated: <i>Section 4: Package mechanical data</i> and added <i>Section 5: Packaging mechanical data</i>

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